

DESCRIPTION

The RH117 is a 3-terminal positive adjustable regulator capable of supplying up to 0.5A (H package) or 1.5A (K package). The output is adjusted using two external resistors for a range of 1.2V to 37V. The devices have full current limit thermal overload safe area protection, all of which remain functional even if the adjustment terminal is disconnected.

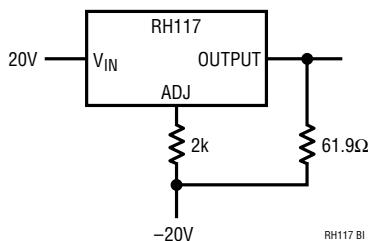
The wafer lots are processed to LTC's in-house Class S flow to yield circuits usable in stringent military applications. In addition to 883 processing, the RH117 is subjected to 100% burn-in in thermal limit.

ABSOLUTE MAXIMUM RATINGS

Power Dissipation	Internally Limited
Input-to-Output Voltage Differential	40V
Operating Junction Temperature Range	-55°C to 150°C
Storage Temperature Range	-65°C to 150°C
Lead Temperature (Soldering, 10 sec)	300°C

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BURN-IN CIRCUIT



PACKAGE/ORDER INFORMATION

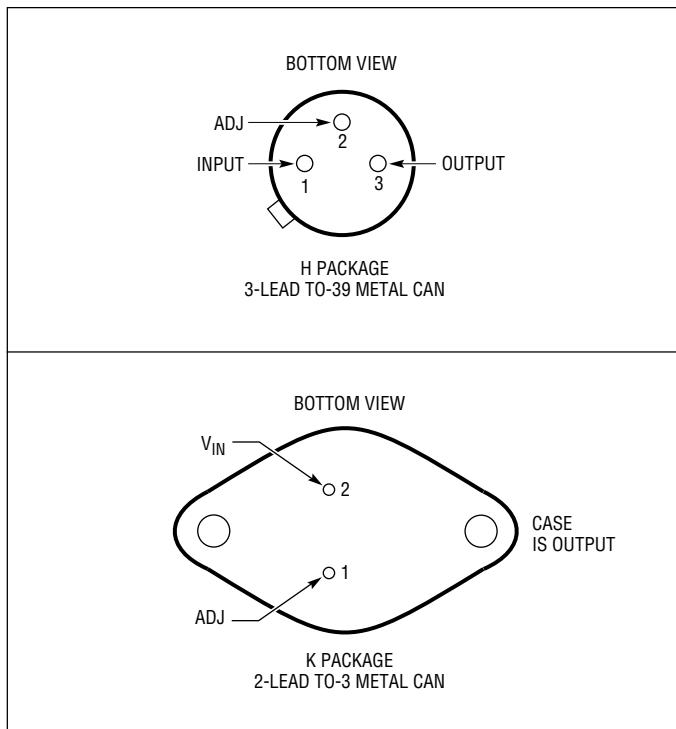


TABLE 1: ELECTRICAL CHARACTERISTICS (Preirradiation) (Note 1)

SYMBOL	PARAMETER	CONDITIONS	NOTES	T _J = 25°C			SUB-GROUP	-55°C			SUB-GROUP	UNITS
				MIN	TYP	MAX		T _J	MIN	TYP		
V _{REF}	Reference Voltage	3V (V _{IN} - V _{OUT}) 40V, 10mA I _{OUT} I _{MAX} , P _P MAX		1.20	1.30	1	1	1.20	1.30	1	2,3	V
V _{OUT} V _{IN}	Line Regulation	3V (V _{IN} - V _{OUT}) 40V, I _{OUT} = 10mA	2		0.02	1			0.05	1	2,3	%/V
V _{OUT} I _{OUT}	Load Regulation	10mA I _{OUT} I _{MAX} , V _{OUT} 5V 10mA I _{OUT} I _{MAX} , V _{OUT} 5V	2		15	1		50	1	2,3	mV	
	Thermal Regulation	20ms Pulse			0.07	1						%/W
	Ripple Rejection	V _{OUT} = 10V, f = 120Hz, C _{ADJ} = 0			65			65				dB
		V _{OUT} = 10V, f = 120Hz, C _{ADJ} = 10μF	3	66				66				dB
I _{ADJ}	Adjust Pin Current				100	1		100	1	2,3	μA	
I _{ADJ}	Adjust Pin Current Change	10mA I _{OUT} I _{MAX} 2.5V (V _{IN} - V _{OUT}) 40V, I _{OUT} = 10mA			5	1		5	1	2,3	μA	
I _{MIN}	Minimum Load Current	(V _{IN} - V _{OUT}) = 40V			5	1		5	1	2,3	mA	
	Current Limit	(V _{IN} - V _{OUT}) 15V H Package K Package		0.5 1.5		1	0.5 1.5			2,3 2,3	A A	
		(V _{IN} - V _{OUT}) = 40V H Package K Package		0.15 0.30		1					A A	
V _{OUT} Temp	Temperature Stability	-55°C T _J 150°C						1				%
V _{OUT} Time	Long Term Stability	T _A = 125°C	3						1			%
e _n	RMS Output Noise	10Hz f 10kHz			0.001							%
θ _{JC}	Thermal Resistance (Junction to Case)	H Package K Package	3 3		15 3							°C/W °C/W

TABLE 1A: ELECTRICAL CHARACTERISTICS (Postirradiation) (Note 4)

SYMBOL	PARAMETER	CONDITIONS	NOTES	10KRAD(Si)		20KRAD(Si)		50KRAD(Si)		100KRAD(Si)		UNITS
				MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
V _{REF}	Reference Voltage	3V (V _{IN} - V _{OUT}) 40V, 10mA I _{OUT} I _{MAX} , P _P MAX		1.20	1.30	1.20	1.30	1.20	1.30	1.20	1.30	V
V _{OUT} V _{IN}	Line Regulation	3V (V _{IN} - V _{OUT}) 40V, I _{OUT} = 10mA	2		0.02		0.02		0.02		0.03	%/V
V _{OUT} I _{OUT}	Load Regulation	10mA I _{OUT} I _{MAX} , V _{OUT} 5V 10mA I _{OUT} I _{MAX} , V _{OUT} 5V	2		36		42		48		60	mV
			2		0.72		0.84		0.96		1.20	%

TABLE 1A: ELECTRICAL CHARACTERISTICS (Postirradiation) (Note 5)

SYMBOL	PARAMETER	CONDITIONS	NOTES	10KRAD(SI) MIN	10KRAD(SI) MAX	20KRAD(SI) MIN	20KRAD(SI) MAX	50KRAD(SI) MIN	50KRAD(SI) MAX	100KRAD(SI) MIN	100KRAD(SI) MAX	UNITS
I _{ADJ}	Adjust Pin Current			100		100		100		100		μA
I _{ADJ}	Adjust Pin Current Change	10mA I _{OUT} MAX		5		5		5		5		μA
		2.5V (V _{IN} - V _{OUT}) 40V, I _{OUT} = 10mA		5		5		5		5		μA
I _{MIN}	Minimum Load Current	(V _{IN} - V _{OUT}) = 40V		5		5		5		5		mA
	Current Limit	(V _{IN} - V _{OUT}) 15V	H Package K Package	0.5 1.5		0.5 1.5		0.5 1.5		0.5 1.5		A
		(V _{IN} - V _{OUT}) = 40V	H Package K Package	0.15 0.30		0.15 0.30		0.15 0.30		0.15 0.30		A

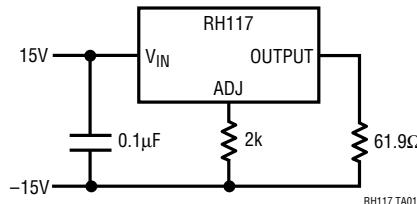
Note 1: Unless otherwise specified, these specifications apply for V_{IN} - V_{OUT} = 5V; and I_{OUT} = 0.1A for the H package (TO-39) and I_{OUT} = 0.5A for the K package (TO-3) package. Although power dissipation is internally limited, these specifications are applicable for power dissipations of 2W for the TO-39 and 20W for the TO-3. I_{MAX} is 0.5A for the TO-39 and 1.5A for the TO-3.

Note 2: Regulation is measured at a constant junction temperature using pulse testing with a low duty cycle. Changes in output voltage due to heating effects are covered under the specification for thermal regulation.

Note 3: Guaranteed by design, characterization or correlation to other tested parameters.

Note 4: T_J = 25°C unless otherwise noted.

TOTAL DOSE BIAS CIRCUIT

**TABLE 2: ELECTRICAL TEST REQUIREMENTS**

MIL-STD-883 TEST REQUIREMENTS	SUBGROUP
Final Electrical Test Requirements (Method 5004)	1*,2,3
Group A Test Requirements (Method 5005)	1,2,3
Group C and D End Point Electrical Parameters (Method 5005)	1

* PDA Applies to subgroup 1. See PDA Test Notes.

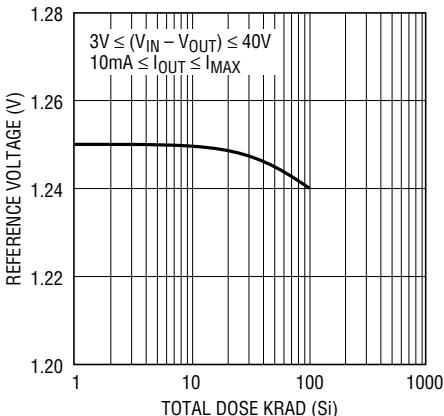
PDA Test Notes

The PDA is specified as 5% based on failures from group A, subgroup 1, tests after cooldown as the final electrical test in accordance with method 5004 of MIL-STD-883 Class B. The verified failures of group A, subgroup 1, after burn-in divided by the total number of devices submitted for burn-in in that lot shall be used to determine the percent for the lot.

Linear Technology Corporation reserves the right to test to tighter limits than those given.

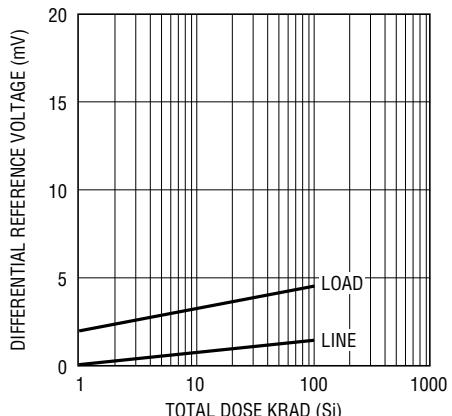
TYPICAL PERFORMANCE CHARACTERISTICS

Reference Voltage



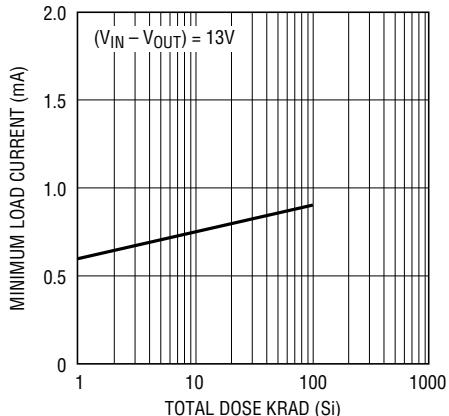
RH117 G01

Regulation



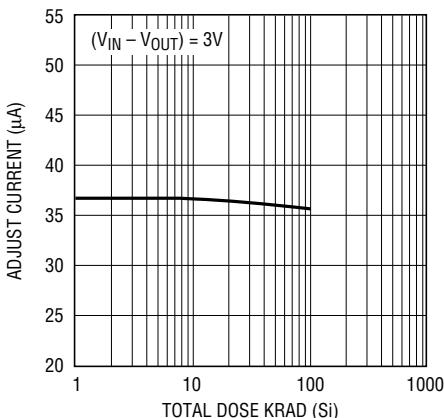
RH117 G02

Minimum Load Current



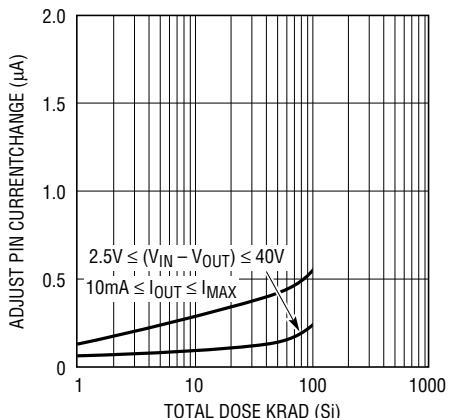
RH117 G03

Adjust Pin Current



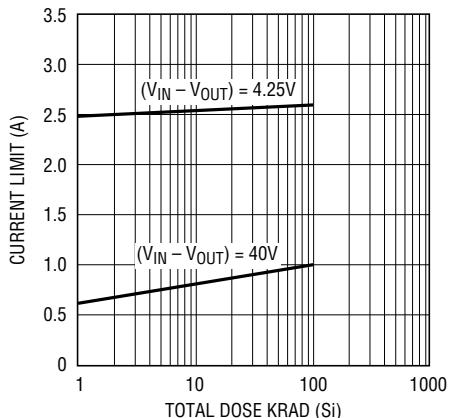
RH117 G04

Adjust Pin Current Change



RH117 G05

Current Limit



RH117 G06

I.D. No. 66-11-0117 Rev. B 0796